

**Search Notes**

Application/Control No.

10/691,115

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under  
Reexamination

ANDRYS ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	285	9/26/2005	NKV
330	296		
327	309		
	312		
	321		
	322		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
See Search History Printout		9/21/2007	NKV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	9/21/2007	NKV